

ZXMP3F35N8 30V SO8 P-channel enhancement mode MOSFET

Summary

V _{(BR)DSS} (V)	R _{DS(on)} (Ω)	I _D (A)
-30	0.012 @ V _{GS} =-10V	-17.1
	0.018 @ V _{GS} =-4.5V	



Description

This new generation Trench MOSFET from Zetex has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance making it ideal for battery protection and reverse connection applications

Features

- Low on-resistance
- · Low gate drive
- SO8 package

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Applications

- Power management functions
- Disconnect switches
- · Reverse battery protection

S D D S D D Top view

Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMP3F35N8TA	7	12	500

Device marking

ZXMP 3F35

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain-Source voltage	V_{DSS}	-30	V
Gate-Source voltage	V_{GS}	±20	V
Continuous Drain current @ V _{GS} = -10V; T _A =25°C (b)	I _D	-12.3	V
@ V_{GS} = -10V; T_A =70°C (b)		-9.9	
@ V_{GS} = -10V; T_A =25°C (a)		-9.3	
@ V_{GS} = -10V; T_L =25°C ^(d)		-17.1	
Pulsed Drain current (C)	I _{DM}	-58	Α
Continuous Source current (Body diode) (b)	Is	-4.9	Α
Pulsed Source current (Body diode) (C)	I _{SM}	-58	Α
Power dissipation at T _A =25°C (a)	P _D	1.56	W
Linear derating factor		12.5	mW/°C
Power dissipation at T _A =25°C (b)	P _D	2.8	W
Linear derating factor		22.2	mW/°C
Power dissipation at T _L =25°C (d)	P _D	5.35	W
Linear derating factor		42.9	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Value	Unit	
Junction to ambient ^(a)	$R_{ heta JA}$	80	°C/W	
Junction to ambient ^(b)	$R_{ heta JA}$	45	°C/W	
Junction to lead ^(d)	$R_{ hetaJL}$	23.33	°C/W	

NOTES:

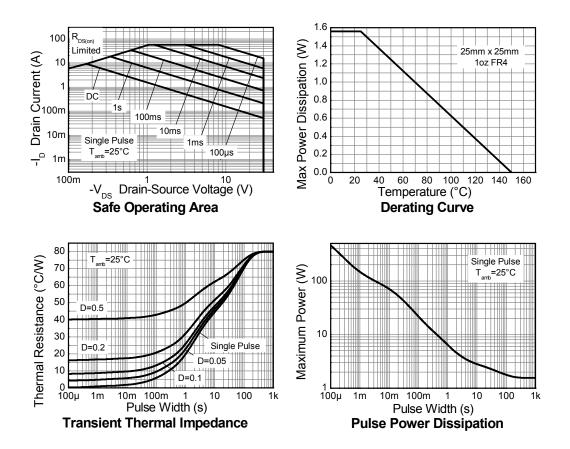
⁽a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

⁽b) Mounted on FR4 PCB measured at $t \le 10$ sec.

⁽c) Repetitive rating on 25mm x 25mm FR4 PCB, D=0.02, pulse width 300us – pulse width limited by maximum junction temperature.

⁽d) Thermal resistance from junction to solder-point (at the end of the drain lead).

Thermal characteristics

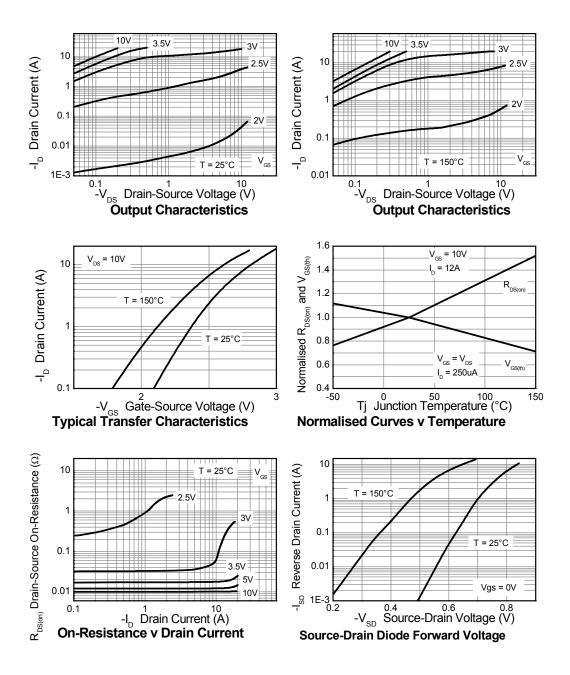


Electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

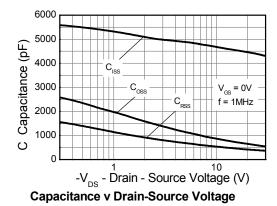
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V _{(BR)DSS}	-30			٧	$I_D = -250 \mu A, V_{GS} = 0 V$
Zero Gate voltage Drain current	I _{DSS}			-1.0	μA	V _{DS} =-30V, V _{GS} =0V
Gate-Body leakage	I _{GSS}			100	nA	V_{GS} =±20V, V_{DS} =0V
Gate-Source threshold voltage	V _{GS(th)}	-1.4		-2.6	V	I_D = -250 μ A, V_{DS} = V_{GS}
Static Drain-Source on-state resistance ^(*)	R _{DS(on)}			0.012 0.018	Ω	V _{GS} = -10V, I _D = -12A V _{GS} = -4.5V, I _D = -10A
Forward Transconductance (*) (†)	g _{fs}		35		S	V _{DS} = -15V, I _D = -12A
Dynamic ^(†)						
Input capacitance	C _{iss}		4600		pF	
Output capacitance	C _{oss}		730		pF	V _{DS} = -15V, V _{GS} =0V
Reverse transfer capacitance	C _{rss}		466		pF	f=1MHz
Switching (‡)(†)						
Turn-on-delay time	t _{d(on)}		5.4		ns	
Rise time	t _r		9.9		ns	V _{DD} = -15V, V _{GS} = -10V
Turn-off delay time	t _{d(off)}		103		ns	I _D = -1A
Fall time	t _f		55.6		ns	$R_G \cong 6.0\Omega$,
Gate charge					_	
Total Gate charge	Qg		77.1		nC	
Gate-Source charge	Q _{gs}		11.6		nC	V _{DS} = -15V, V _{GS} = -10V
Gate-Drain charge	Q _{gd}		15.7		nC	I _D = -12A
Source-Drain diode	· · · · · ·		•		•	
Diode forward voltage (*)	V _{SD}		-0.73	-1.2	V	I _S = -1.7A,V _{GS} =0V
Reverse recovery time (‡)	t _{rr}		20.6		ns	-I _S = -3A,di/dt=100A/μs
Reverse recovery charge ^(‡)	Q _{rr}		12.4		nC	153Α,αι/αι- 100Α/μ5

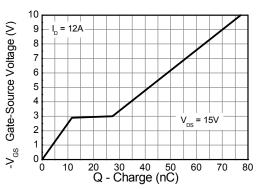
^(*) Measured under pulsed conditions. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$. (†)Switching characteristics are independent of operating junction temperature. (‡)For design aid only, not subject to production testing

Typical characteristics



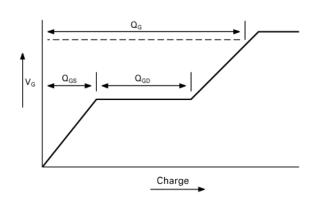
Typical characteristics

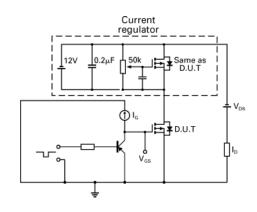




Gate-Source Voltage v Gate Charge

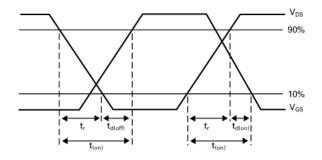
Test circuits

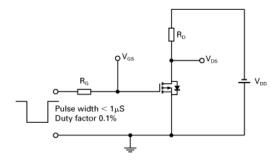




Basic gate charge waveform

Gate charge test circuit

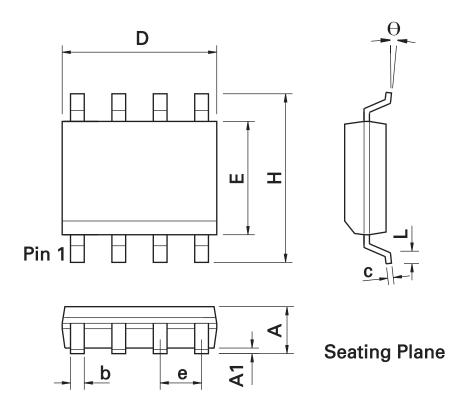




Switching time waveforms

Switching time test circuit

Package outline SO8



SO8 Package Information

DIM	Inc	hes	Millin	neters	DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	U	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	1	_	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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